

# Software Programmable Gain Amplifier

AD526

#### **FEATURES**

Digitally Programmable Binary Gains from 1 to 16 Two-Chip Cascade Mode Achieves Binary Gain from 1 to 256

Gain Error:

0.01% Max, Gain = 1, 2, 4 (C Grade) 0.02% Max, Gain = 8, 16 (C Grade) 0.5 ppm/°C Drift Over Temperature Fast Settling Time 10 V Signal Change:

0.01% in 4.5 μs (Gain = 16)

Gain Change:

0.01% in 5.6 μs (Gain = 16)

Low Nonlinearity: ±0.005% FSR Max (J Grade)

**Excellent DC Accuracy:** 

Offset Voltage: 0.5 mV Max (C Grade) Offset Voltage Drift: 3 μV/°C (C Grade)

**TTL-Compatible Digital Inputs** 

#### PRODUCT DESCRIPTION

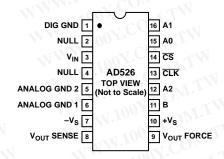
The AD526 is a single-ended, monolithic software programmable gain amplifier (SPGA) that provides gains of 1, 2, 4, 8 and 16. It is complete, including amplifier, resistor network and TTL-compatible latched inputs, and requires no external components.

Low gain error and low nonlinearity make the AD526 ideal for precision instrumentation applications requiring programmable gain. The small signal bandwidth is 350 kHz at a gain of 16. In addition, the AD526 provides excellent dc precision. The FET-input stage results in a low bias current of 50 pA. A guaranteed maximum input offset voltage of 0.5 mV max (C grade) and low gain error (0.01%, G = 1, 2, 4, C grade) are accomplished using Analog Devices' laser trimming technology.

To provide flexibility to the system designer, the AD526 can be operated in either latched or transparent mode. The force/sense configuration preserves accuracy when the output is connected to remote or low impedance loads.

The AD526 is offered in one commercial (0°C to +70°C) grade, J, and three industrial grades, A, B and C, which are specified from -40°C to +85°C. The S grade is specified from -55°C to +125°C. The military version is available processed to MIL-STD 883B, Rev C. The J grade is supplied in a 16-lead plastic DIP, and the other grades are offered in a 16-lead hermetic side-brazed ceramic DIP.

#### PIN CONFIGURATION



#### APPLICATION HIGHLIGHTS

- Dynamic Range Extension for ADC Systems: A single AD526 in conjunction with a 12-bit ADC can provide 96 dB of dynamic range for ADC systems.
- 2. **Gain Ranging Preamps:** The AD526 offers complete digital gain control with precise gains in binary steps from 1 to 16. Additional gains of 32, 64, 128 and 256 are possible by cascading two AD526s.

#### ORDERING GUIDE

Model	Temperature Range	Package Descriptions	Package Options
AD526JN	Commercial	16-Lead Plastic DIP	N-16
AD526AD	Industrial	16-Lead Cerdip	D-16
AD526BD	Industrial	16-Lead Cerdip	D-16
AD526CD	Industrial	16-Lead Cerdip	D-16
AD526SD	Military	16-Lead Cerdip	D-16
AD526SD/883B	Military	16-Lead Cerdip	D-16
5962-9089401MEA*	Military	16-Lead Cerdip	D-16

<sup>\*</sup>Refer to official DESC drawing for tested specifications.

#### REV. D

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# AD526—SPECIFICATIONS (@ $V_s = \pm 15 \text{ V}$ , $R_L = 2 \text{ k}\Omega$ and $T_A = +25 ^{\circ}\text{C}$ unless otherwise noted)

Model COMMAN	Min	AD526J Typ	Max	Min	AD526A Typ	Max	A Min	D526B/S Typ	Max	Al Min	D526C Typ	Max	Units
GAIN	W	MAN	ony.	Ober	WT		MW	44.	OV.C	-117			
Gain Range				CON						OMr.			
(Digitally Programmable)	1,	2, 4, 8, 1	6		1, 2, 4, 8,	16	1	, 2, 4, 8,	16	1,	2, 4, 8,	16	
Gain Error				T.CO			1			COR			
Gain = 1			0.05			0.02			0.01	CON		0.01	%
Gain = 2			0.05	Y.C		0.03			0.02			0.01	%
Gain = 4			0.10	-7.0		0.03			0.02	<7 CO		0.01	%
Gain = 8			0.15	10x.		0.07			0.04	7.		0.02	%
Gain = 16			0.15			0.07			0.04	V.C		0.02	%
Gain Error Drift				100 .						10 -		-1	
Over Temperature	N			. 00						00 X .		TW	
G = 1	1	0.5	2.0	700	0.5	2.0	4.1	0.5	2.0	×7	0.5	2.0	ppm/°C
G = 2	W	0.5	2.0	100	0.5	2.0	N	0.5	2.0	100 %	0.5	2.0	ppm/°C
G = 4	- «T	0.5	3.0	W.ro.	0.5	3.0	K X I	0.5	3.0		0.5	3.0	ppm/°C
G = 8	IN	0.5	5.0	-x1 10	0.5	5.0	1	0.5	5.0	u.100	0.5	5.0	ppm/°C
G = 16		1.0	5.0	111	1.0	5.0	TV	1.0	5.0	. 00	1.0	5.0	ppm/°C
Gain Error (T <sub>MIN</sub> to T <sub>MAX</sub> )	1.1.			-TXN.			1			M.In.		$OMr_r$	
Gain = 1	TV		0.06	Maria		0.03	TW		0.02	-10		0.015	%
Gain = 2	M. r		0.06			0.04			0.03	MIN'T		0.015	%
Gain = 4	- 17		0.12	114.		0.04	TY		0.03	_ 1		0.015	%
Gain = 8	$0 Nr \cdot r$		0.17	-111		0.08	N. T.		0.05	$M_{M}$ .		0.03	%
Gain = 16	717		0.17	M		0.08	1.1/		0.05	- 1		0.03	%
Nonlinearity	$10^{Mr}$			TVV			72.			MIN V		Y.Co	
Gain = 1			0.005	44		0.005	OM.		0.005			0.0035	% FSR
Gain = 2	CO.		0.001	W		0.001			0.001	MAN		0.001	% FSR
Gain = 4	. 001		0.001			0.001	$COM_1$		0.001			0.001	% FSR
Gain = 8			0.001	V		0.001			0.001	10.		0.001	% FSR
Gain = 16	-7 CC		0.001			0.001	$^{1}$ CO $_{2}$		0.001	11		0.001	% FSR
Nonlinearity ( $T_{MIN}$ to $T_{MAX}$ )												700 -	
Gain = 1	N.C		0.01			0.01	V.CC		0.01	V		0.007	% FSR
Gain = 2	00 r.		0.001			0.001	- 0		0.001			0.001	% FSR
Gain = 4	NO.		0.001			0.001	W.V		0.001	-		0.001	% FSR
Gain = 8	100		0.001			0.001	×7 (		0.001			0.001	% FSR
Gain = 16	400		0.001		W.	0.001	00x		0.001		- A.A.,	0.001	% FSR
VOLTAGE OFFSET, ALL GAINS	1.10			(N)			CON					N N N	
Input Offset Voltage	x 101	0.4	1.5		0.25	0.7	700.	0.25	0.5	. 7	0.25	0.5	mV
Input Offset Voltage Drift Over	MA.			W			400					111	
Temperature	W.10	5	20	L '	3	10	N'Inc	3	10	- 1	3	10	μV/°C
Input Offset Voltage				TW			10					N	$^{1}100^{3}$
$T_{MIN}$ to $T_{MAX}$	WW.		2.0			1.0	M.r.		0.8	-XX		0.8	mV
Input Offset Voltage vs. Supply							-xx1 1			7.4.			
$(V_S \pm 10\%)$	80			80			84			90		WW	dB
INPUT BIAS CURRENT		N 100		Mir	7		-111	The	- COD	1.	T	-11	M.T.
Over Input Voltage Range ± 10 V	WW	50	150	- 47	50	150	144	50	150	VIII	50	150	pA
			27		-30		AT W	7.50	<del>3 ČO</del>	11	N	100	P
ANALOG INPUT	11/1/			100			M			VI.7		7	
CHARACTERISTICS	-31			$CO_{\mathbb{N}}$ ,			WW			DE 41			
Voltage Range	111			100						OM			
(Linear Operation)	±10	±12		±10	±12		±10	±12		±10	±12		V
Capacitance		5	700	- 00	5	<1		5	To.		5		pF
RATED OUTPUT		MAL	1100	X.	TIME								
Voltage	±10	±12		±10	±12		±10	±12		±10	±12		V
Current ( $V_{OUT} = \pm 10 \text{ V}$ )		±10		±5	±10		±5	±10		±5	±10		mΑ
Short-Circuit Current	15	30		15	30		15	30		15	30		mA
DC Output Resistance		0.002		na.	0.002			0.002			0.002		Ω
Load Capacitance		0.002			0.002			0.002			0.002		
(For Stable Operation)		700			700			700			700		pF
(1 of otable Operation)		100			100			100		1	100		h <sub>T</sub>

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Model	Min	AD526J Typ	Max	Min	AD526. Typ	A Max	Min Al	D526B/S Typ	Max	Min A	D5260 Typ	C Max	Units
NOISE, ALL GAINS	MM.	100	Y.Co	T.M			TXX	100 X	TOM!	M			
Voltage Noise, RTI	WW	W		171	W		MAN AL	400		TW			
0.1 Hz to 10 Hz		3		OIV	3		TINY	3		- XX	3		μV p
Voltage Noise Density, RTI f = 10 Hz	11/1	70			70		11.	70		T.T.A.	70		nV√Ī
f = 100  Hz	***	70 60		$\mathbb{C}_{\mathbf{O}_{2i}}$	60			60		- 1	60		nV√.
f = 1  kHz	1	30			30			30		Mr.	30		nV√
f = 1  KHz f = 10  kHz		25			25		W	25		71.7	35		nV√
DYNAMIC RESPONSE			1.10-	o CO	1	N.	11	1	ON.C	J.N.B.	TW		
-3 dB Bandwidth (Small Signal)				1.			1			Mo			
G = 1		4.0		N.C	4.0		1	4.0			4.0		MH
G = 2		2.0		0 -	2.0			2.0		$CO_{\overline{D}}$	2.0		MH
G = 2	1	1.5		00X.	1.5			1.5			1.5		MH
G = 8	<b>S</b> T	0.65		~ 1	0.65			0.65		V.CU	0.65		MH
G = 16	()	0.35		$100_{J}$	0.35			0.35		01	0.35		MH
Signal Settling Time to 0.01%	W				Y.Co		N			N.C.			
$(\Delta V_{OUT} = \pm 10 \text{ V})$	-			N.100			-<1			-7 (			
G = 1		2.1	4	-110	2.1	4		2.1	4	00x.	2.1	4	μs
G = 2	- 1	2.5	5	W.r.	2.5	5	-11	2.5	5		2.5	5	μs
G = 4	TW	2.7	5	-xx1 1	2.7	5	1.11	2.7	5	700 -	2.7	5	μs
G = 8		3.6	7	111.	3.6	7	WT.	3.6	7	400	3.6	7	μs
G = 16	Mir	4.1	7	TIN.	4.1	7	1.1	4.1	7	1.70	4.1	7	μs
Full Power Bandwidth	LIT			14			WILL			×1 10			IN
G = 1, 2, 4	DIVI.	0.10		KT WW	0.10		Mr.	0.10		11	0.10		MH
G = 8, 16	110	0.35			0.35		VV.7.	0.35		T.V.1	0.35		MH
Slew Rate	Ohr			WW			) - T						11
G = 1, 2, 4	4	6		4	6		4	6		4	6		V/µs
G = 8, 16	18	24		18	24	007.	18	24		18	24	17.	V/µs
DIGITAL INPUTS	+ CO			- 1			$CO_{D_{2}}$			VIV			Dry
$(T_{MIN} \text{ to } T_{MAX})$				11			Mos						OD
Input Current ( $V_H = 5 \text{ V}$ )	60	100	140	60	100	140	60	100	140	60	100	140	μA
Logic "1"	2		6	2		6	2		6	2		6	V
Logic "0"	0		0.8	0	1111	0.8	0	T	0.8	0	100	0.8	V
TIMING <sup>1</sup>	~1						V.C			W			7.0
$(V_L = 0.2 \text{ V}, V_H = 3.7 \text{ V})$	100 7.						00 -						-7
A0, A1, A2	1.003						OOY.						DX.
$T_{C}$	50			50			50			50			ns
$T_{S}$	30			30			30			30			ns
$T_{H}$	30			30			30			30			ns
В	<b>KSI</b> 10						$N_{100}$						Too
$T_{\rm C}$	50			50			50			50			ns
$T_s$	40			40			40			40			ns
$T_{H}$	10	1007		10			10	70.7.	-011	30		-41	ns
TEMPERATURE RANGE	WW		COA			N.	MAN		JUL T	W		WW	
Specified Performance	0		+70	-40		+85	-40/-55		+85/+125	- 4		+85	°C
Storage	-65	400	+125	-65	N.	+150	-65	1001	+150	-65		+150	°C
POWER SUPPLY				DIM			WWW						
Operating Range	±4.5		±16.5	±4.5		±16.5	±4.5		±16.5	±4.5		±16.5	V
Positive Supply Current	***	10	14	Oh	10	14	WW	10	14		10	14	mA
Negative Supply Current	NA.	10	13	Mon	10	13	41	10	13		10	13	mA
PACKAGE OPTIONS	1/1	MAIN	A OOY	CO.	WT								
Plastic (N-16)	A	D526JN											
Ceramic DIP (D-16)	1	MAL.		AI	D526AD		AD526B	D AD5	26SD		AD52	26CD	
•	1			1			1		26SD/883B	1			1

#### NOTES

<sup>&</sup>lt;sup>1</sup>Refer to Figure 25 for definitions. FSR = Full Scale Range = 20 V. RTI = Referred to Input.

Specifications subject to change without notice.

Specifications shown in boldface are tested on all production units at final electrical test. All min and max specifications are guaranteed, although only those shown in boldface are tested on all production units.

# **AD526**—Typical Performance Characteristics

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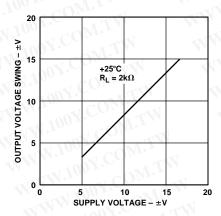


Figure 1. Output Voltage Swing vs. Supply Voltage, G = 16

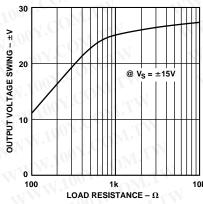


Figure 2. Output Voltage Swing vs. Load Resistance

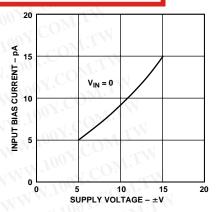


Figure 3. Input Bias Current vs. Supply Voltage

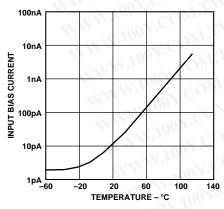


Figure 4. Input Bias Current vs. Temperature

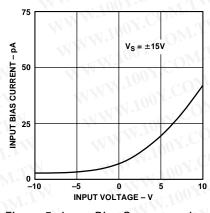


Figure 5. Input Bias Current vs. Input Voltage

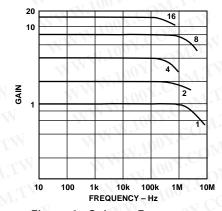


Figure 6. Gain vs. Frequency

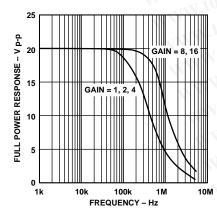


Figure 7. Large Signal Frequency Response

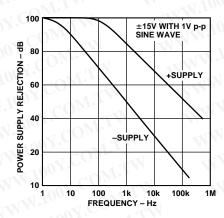


Figure 8. PSRR vs. Frequency

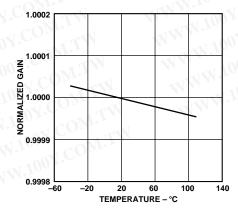


Figure 9. Normalized Gain vs. Temperature, Gain = 1

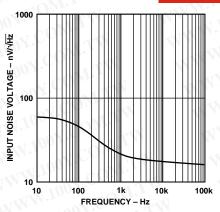


Figure 10. Noise Spectral Density

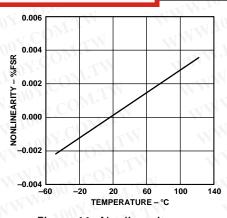


Figure 11. Nonlinearity vs. Temperature, Gain = 1

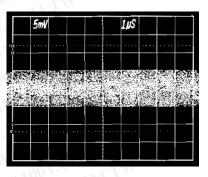


Figure 12. Wideband Output Noise, G = 16 (Amplified by 10)

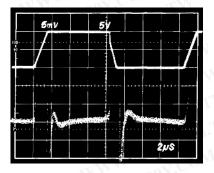


Figure 13. Large Signal Pulse Response and Settling Time,\* G = 1

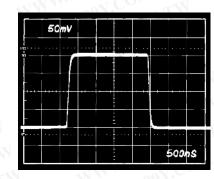


Figure 14. Small Signal Pulse Response, G = 1

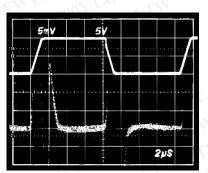


Figure 15. Large Signal Pulse Response and Settling Time,\* G = 2

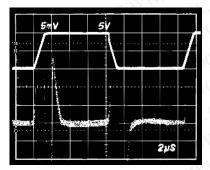


Figure 16. Small Signal Pulse Response, G = 2

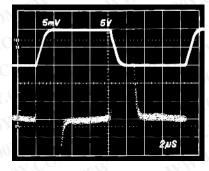


Figure 17. Large Signal Pulse Response and Settling Time,\* G = 4

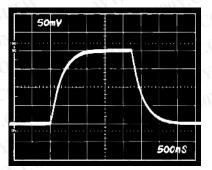


Figure 18. Small Signal Pulse Response, G = 4

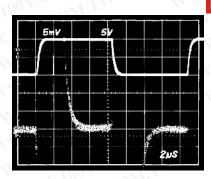


Figure 19. Large Signal Pulse Response and Settling Time,\* G = 8



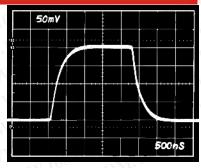


Figure 20. Small Signal Pulse Response, G = 8

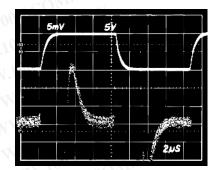


Figure 21. Large Signal Pulse Response and Settling Time,\* G = 16

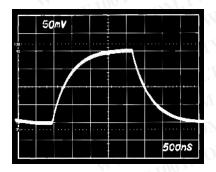


Figure 22. Small Signal Pulse Response, Gain = 16

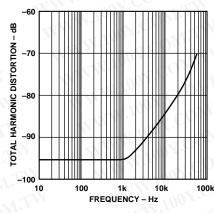


Figure 23. Total Harmonic Distortion vs. Frequency Gain = 16

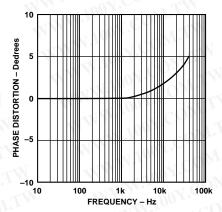


Figure 24. Phase Distortion vs. Frequency, Gain = 16

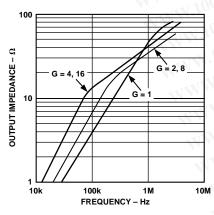


Figure 25. Output Impedance vs. Frequency

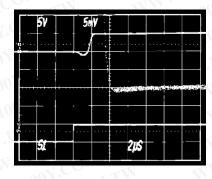


Figure 26. Gain Change Settling Time,\*\* Gain Change: 1 to 2

-6-

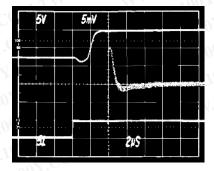
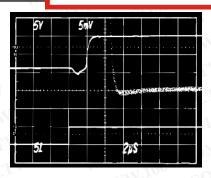


Figure 27. Gain Change Settling Time,\*\* Gain Change 1 to 4

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<sup>\*</sup>For Settling Time Traces, 0.01% = 1/2 Vertical Division

<sup>\*\*</sup>Scope Traces are: Top: Output Transition; Middle: Output Settling; Bottom: Digital Input.



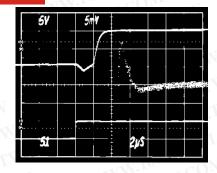


Figure 28. Gain Change Settling Time,\* Gain Change 1 to 8

Figure 29. Gain Change Settling Time,\* Gain Change 1 to 16

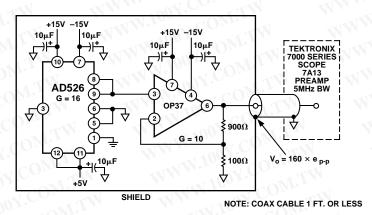


Figure 30. Wideband Noise Test Circuit

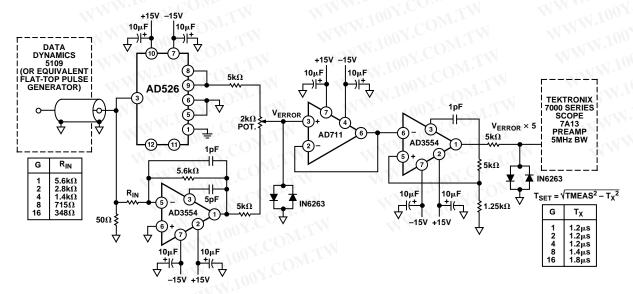


Figure 31. Settling Time Test Circuit

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#### THEORY OF OPERATION

The AD526 is a complete software programmable gain amplifier (SPGA) implemented monolithically with a drift-trimmed BiFET amplifier, a laser wafer trimmed resistor network, JFET analog switches and TTL compatible gain code latches.

A particular gain is selected by applying the appropriate gain code (see Table I) to the control logic. The control logic turns on the JFET switch that connects the correct tap on the gain network to the inverting input of the amplifier; all unselected JFET gain switches are off (open). The "on" resistance of the gain switches causes negligible gain error since only the amplifier's input bias current, which is less than 150 pA, actually flows through these switches.

The AD526 is capable of storing the gain code, (latched mode), B, A0, A1, A2, under the direction of control inputs  $\overline{\text{CLK}}$  and  $\overline{\text{CS}}$ . Alternatively, the AD526 can respond directly to gain code changes if the control inputs are tied low (transparent mode).

For gains of 8 and 16, a fraction of the frequency compensation capacitance (C1 in Figure 32) is automatically switched out of the circuit. This increases the amplifier's bandwidth and improves its signal settling time and slew rate.

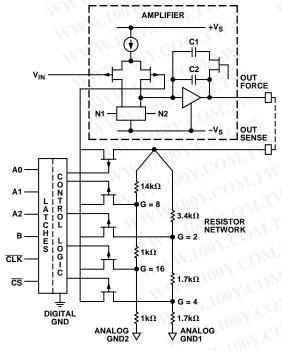


Figure 32. Simplified Schematic of the AD526

#### TRANSPARENT MODE OF OPERATION

In the transparent mode of operation, the AD526 will respond directly to level changes at the gain code inputs (A0, A1, A2) if B is tied high and both  $\overline{\text{CS}}$  and  $\overline{\text{CLK}}$  are allowed to float low.

After the gain codes are changed, the AD526's output voltage typically requires  $5.5~\mu s$  to settle to within 0.01% of the final value. Figures 26 to 29 show the performance of the AD526 for positive gain code changes.

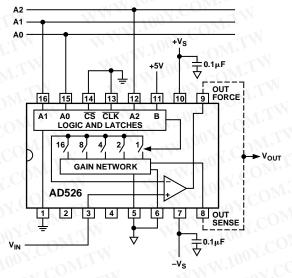


Figure 33. Transparent Mode

#### LATCHED MODE OF OPERATION

The latched mode of operation is shown in Figure 34. When either  $\overline{\text{CS}}$  or  $\overline{\text{CLK}}$  go to a Logic "1," the gain code (A0, A1, A2, B) signals are latched into the registers and held until both  $\overline{\text{CS}}$  and  $\overline{\text{CLK}}$  return to "0." *Unused*  $\overline{\text{CS}}$  or  $\overline{\text{CLK}}$  inputs should be tied to ground. The  $\overline{\text{CS}}$  and  $\overline{\text{CLK}}$  inputs are functionally and electrically equivalent.

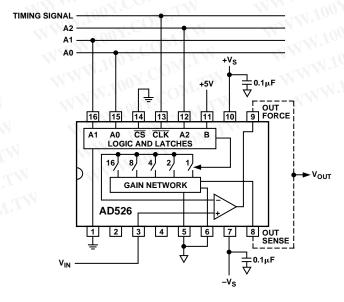


Figure 34. Latched Mode

**AD526** 

#### TIMING AND CONTROL

Table I. Logic Input Truth Table

17		Code A0		$\frac{\text{Control}}{\text{CLK}} (\overline{\text{CS}} = 0)$	Condition Gain	Condition
$\overline{\mathbf{x}}$	X	X	X	1	Previous State	Latched
0	0	0	1	0	1. 10	Transparent
0	0	17.	1	0	2	Transparent
0	111	0	1	0	4	Transparent
0	1	1	1	0	8	Transparent
1	X	X	1	OM O	16	Transparent
X	X	X	0	0	1	Transparent
X	X	X	0	CO 1 TW	1	Latched
0	0	0	1	CON	1	Latched
0	0	1.4	1	1	2	Latched
0	1	0	1	COI	4	Latched
0	1	1	1	T.M.	8	Latched
1	X	X	1	NY I	16	Latched

NOTE: X = Don't Care.

The specifications on page 3, in combination with Figure 35, give the timing requirements for loading new gain codes.

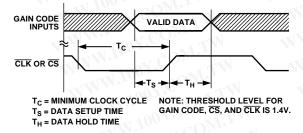


Figure 35. AD526 Timing

#### DIGITAL FEEDTHROUGH

With either  $\overline{\text{CS}}$  or  $\overline{\text{CLK}}$  or both held high, the AD526 gain state will remain constant regardless of the transitions at the A0, A1, A2 or B inputs. However, high speed logic transitions will unavoidably feed through to the analog circuitry within the AD526 causing spikes to occur at the signal output.

This feedthrough effect can be completely eliminated by operating the AD526 in the transparent mode and latching the gain code in an external bank of latches (Figure 36).

To operate the AD526 using serial inputs, the configuration shown in Figure 36 can be used with the 74LS174 replaced by a serial-in/parallel-out latch, such as the 54LS594.

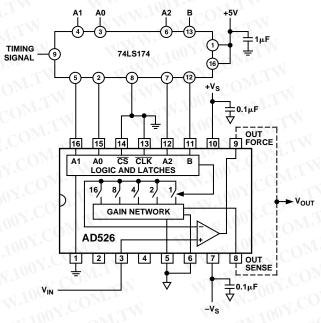


Figure 36. Using an External Latch to Minimize Digital Feedthrough

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#### **GROUNDING AND BYPASSING**

Proper signal and grounding techniques must be applied in board layout so that specified performance levels of precision data acquisition components, such as the AD526, are not degraded.

As is shown in Figure 37, logic and signal grounds should be separate. By connecting the signal source ground locally to the AD526 analog ground Pins 5 and 6, gain accuracy of the AD526 is maintained. This ground connection should not be corrupted by currents associated with other elements within the system.

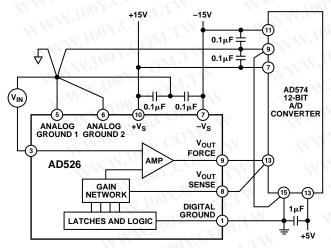


Figure 37. Grounding and Bypassing

Utilizing the force and sense outputs of the AD526, as shown in Figure 38, avoids signal drops along etch runs to low impedance loads.

Table II. Logic Table for Figure 38

V <sub>OUT</sub> /V <sub>IN</sub>	A2	A1	A0
1	_0,00	0	0
2	0	0	1
4	0	1	0
8	0	1	1
16	1	0	0
32 64	1	0	1
64	1	1	0
128	1	1	1

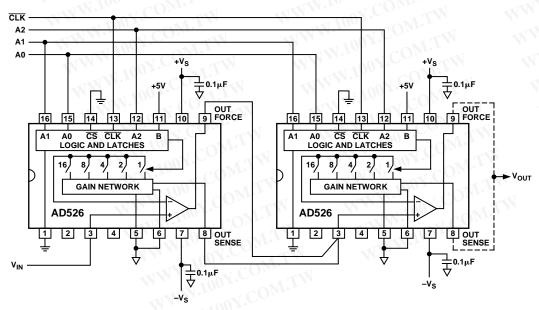


Figure 38. Cascaded Operation

**AD526** 

#### OFFSET NULLING

Input voltage offset nulling of the AD526 is best accomplished at a gain of 16, since the referred-to-input (RTI) offset is amplified the most at this gain and therefore is most easily trimmed. The resulting trimmed value of RTI voltage offset typically varies less than 3  $\mu V$  across all gain ranges.

Note that the low input current of the AD526 minimizes RTI voltage offsets due to source resistance.

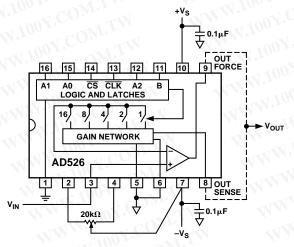


Figure 39. Offset Voltage Null Circuit

#### **OUTPUT CURRENT BOOSTER**

The AD526 is rated for a full  $\pm 10$  V output voltage swing into 2 k $\Omega$ . In some applications, the need exists to drive more current into heavier loads. As shown in Figure 40, a high current booster may be connected "inside the loop" of the SPGA to provide the required current boost without significantly degrading overall performance. Nonlinearities, offset and gain inaccuracies of the buffer are minimized by the loop gain of the AD526 output amplifier.

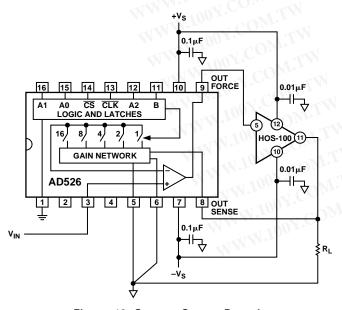


Figure 40. Current Output Boosting

#### **CASCADED OPERATION**

A cascade of two AD526s can be used to achieve binarily weighted gains from 1 to 256. If gains from 1 to 128 are needed, no additional components are required. This is accomplished by using the B pin as shown in Figure 38. When the B pin is low, the AD526 is held in a unity gain stage independent of the other gain code values.

#### OFFSET NULLING WITH A D/A CONVERTER

Figure 41 shows the AD526 with offset nulling accomplished with an 8-bit D/A converter (AD7524) circuit instead of the potentiometer shown in Figure 39. The calibration procedure is the same as before except that instead of adjusting the potentiometer, the D/A converter corrects for the offset error. This calibration circuit has a number of benefits in addition to eliminating the trimpot. The most significant benefit is that calibration can be under the control of a microprocessor and therefore can be implemented as part of an autocalibration scheme. Secondly, dip switches or RAM can be used to hold the 8-bit word after its value has been determined. In Figure 42 the offset null sensitivity, at a gain of 16, is 80  $\mu V$  per LSB of adjustment, which guarantees dc accuracy to the 16-bit performance level.

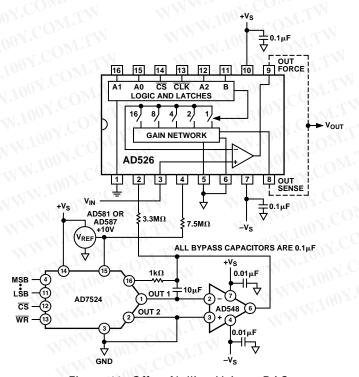


Figure 41. Offset Nulling Using a DAC

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#### **FLOATING-POINT CONVERSION**

High resolution converters are used in systems to obtain high accuracy, improve system resolution or increase dynamic range. There are a number of high resolution converters available with throughput rates of 66.6 kHz that can be purchased as a single component solution; however in order to achieve higher throughput rates, alternative conversion techniques must be employed. A floating point A/D converter can improve both throughput rate and dynamic range of a system.

In a floating point A/D converter (Figure 42), the output data is presented as a 16-bit word, the lower 12 bits from the A/D converter form the mantissa and the upper 4 bits from the digital signal used to set the gain form the exponent. The AD526 programmable gain amplifier in conjunction with the comparator circuit scales the input signal to a range between half scale and full scale for the maximum usable resolution.

The A/D converter diagrammed in Figure 42 consists of a pair of AD585 sample/hold amplifiers, a flash converter, a five-range programmable gain amplifier (the AD526) and a fast 12-bit A/D converter (the AD7572). The floating-point A/D converter achieves its high throughput rate of 125 kHz by overlapping the acquisition time of the first sample/hold amplifier and the settling time of the AD526 with the conversion time of the A/D converter. The first sample/hold amplifier holds the signal for the flash autoranger, which determines which binary quantum

the input falls within, relative to full scale. Once the AD526 has settled to the appropriate level, then the second sample/hold amplifier can be put into hold which holds the amplified signal while the AD7572 perform its conversion routine. The acquisition time for the AD585 is 3  $\mu s$ , and the conversion time for the AD7572 is 5  $\mu s$  for a total of 8  $\mu s$ , or 125 kHz. This performance relies on the fast settling characteristics of the AD526 after the flash autoranging (comparator) circuit quantizes the input signal. A 16-bit register holds the 3-bit output from the flash autoranger and the 12-bit output of the AD7572.

The A/D converter in Figure 42 has a dynamic range of 96 dB. The dynamic range of a converter is the ratio of the full-scale input range to the LSB value. With a floating-point A/D converter the smallest value LSB corresponds to the LSB of the monolithic converter divided by the maximum gain of the PGA. The floating point A/D converter has a full-scale range of 5 V, a maximum gain of 16 V/V from the AD526 and a 12-bit A/D converter; this produces:

LSB = ([FSR/ $2^N$ ]/Gain) = ([5 V/4096]/16) = 76  $\mu$ V. The dynamic range in dBs is based on the log of the ratio of the full-scale input range to the LSB; dynamic range = 20 log (5 V/76  $\mu$ V) = 96 dB.

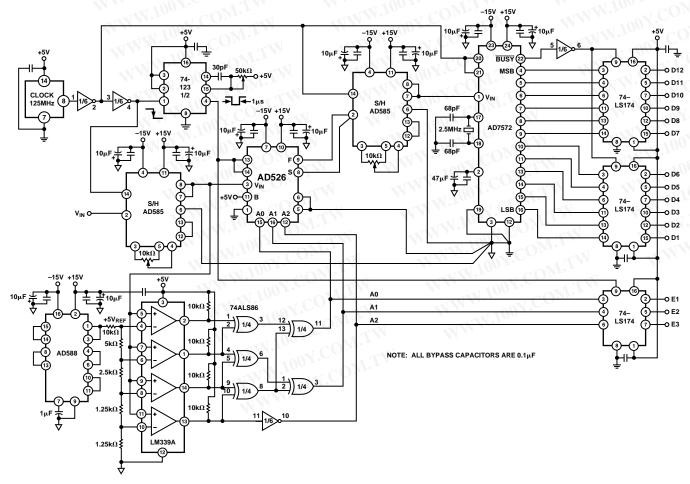


Figure 42. Floating-Point A/D Converter

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AD526

#### HIGH ACCURACY A/D CONVERTERS

Very high accuracy and high resolution floating-point A/D converters can be achieved by the incorporation of offset and gain calibration routines. There are two techniques commonly used for calibration, a hardware circuit as shown in Figure 43 and/or a software routine. In this application the microprocessor is functioning as the autoranging circuit, requiring software overhead; therefore, a hardware calibration technique was applied which reduces the software burden. The software is used to set the gain of the AD526. In operation the signal is converted, and if the MSB of the AD574 is not equal to a Logical 1, the gain is increased by binary steps, up to the maximum gain. This maximizes the full-scale range of the conversion process and insures a wide dynamic range.

The calibration technique uses two point correction, offset and gain. The hardware is simplified by the use of programmable magnitude comparators, the 74ALS528s, which can be "burned" for a particular code. In order to prevent under or over range

hunting during the calibration process, the reference offset and gain codes should be different from the endpoint codes. A calibration cycle consists of selecting whether gain or offset is to be calibrated then selecting the appropriate multiplexer channel to apply the reference voltage to the signal channel. Once the operation has been initiated, the counter, a 74ALS869, drives the D/A converter in a linear fashion providing a small correction voltage to either the gain or offset trim point of the AD574. The output of the A/D converter is then compared to the value preset in the 74ALS528 to determine a match. Once a match is detected, the 74ALS528 produces a low going pulse which stops the counter. The code at the D/A converter is latched until the next calibration cycle. Calibration cycles are under the control of the microprocessor in this application and should be implemented only during periods of converter inactivity.

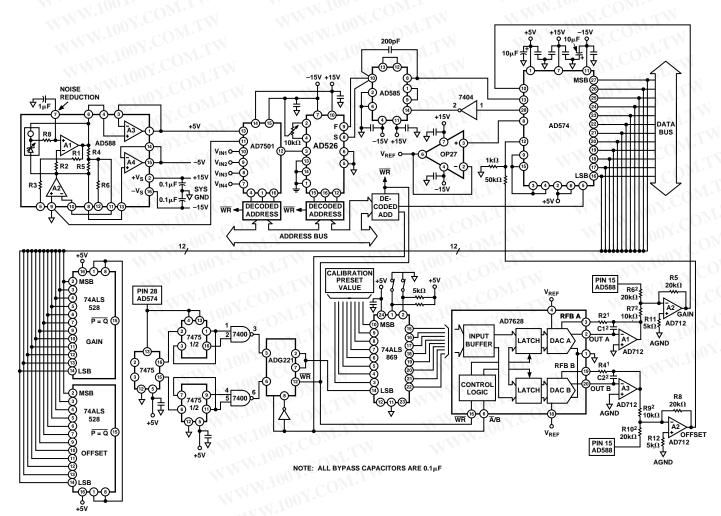


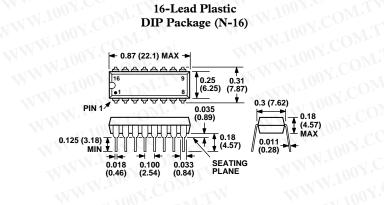
Figure 43. High Accuracy A/D Converter

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Dimensions shown in inches and (mm).

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